

N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a			
60	0.024 at V _{GS} = 10 V	50			
	0.028 at V _{GS} = 4.5 V	40			

FEATURES

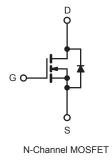
- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC



Ο GDS

Top View

TO-220AB



ABSOLUTE MAXIMUM RATINGS (T_C :	= 25 °C, unl	less otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V _{DS}	60	v
Gate-Source Voltage			V _{GS}	± 20	v
Continuous Drain Current ^f	V _{GS} at 10 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	la la	50	
Continuous Drain Current	VGS AL TO V	T _C = 100 °C	I _D	36	А
Pulsed Drain Current ^a			I _{DM}	200	
Linear Derating Factor				1.0	W/°C
Linear Derating Factor (PCB Mount) ^e				0.025	W/ C
Single Pulse Avalanche Energy ^b			E _{AS}	400	mJ
Maximum Power Dissipation T _C = 25 °C		PD	150	W	
Maximum Power Dissipation (PCB Mount) ^e T _A = 25 °C			3.7	vv	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C
Soldering Recommendations (Peak Temperature) ^d for 10 s				300 ^d	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 179 \text{ }\mu\text{H}$, $R_g = 25 \Omega$, $I_{AS} = 51 \text{ A}$ (see fig. 12). c. $I_{SD} \le 51 \text{ A}$, dl/dt $\le 250 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

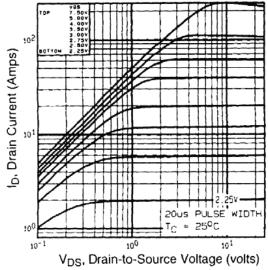
d. 1.6 mm from case.



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP		MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-		62		1			
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-		40		°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 1.0							
lote . When mounted on 1" square PCB (FR-4	or G-10 material)). 1							
SPECIFICATIONS ($T_J = 25 \text{ °C}$, u	inless otherw	ise noted)			1				
PARAMETER	SYMBOL	TES	T CONDITI	IONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 25	50 µA	60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I _D = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V_{GS} , $I_D = 2$	250 μA	1.0	-	2.5		
Gate-Source Leakage	I _{GSS}	,	/ _{GS} = ± 10 '	V	-	-	± 100	nA	
		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V,	$V_{GS} = 0 V,$	T _J = 150 °C	-	-	250	μA	
		V _{GS} = 10 V		= 21 A ^b	_	0.024	-	Ω	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.5 V		= 15 A ^b	-	0.028	-		
Forward Transconductance	g _{fs}		= 25 V, I _D =	21A ^b	23	-	-	S	
Dynamic	010								
Input Capacitance	C _{iss}				_	190			
Output Capacitance	C _{oss}	-	$V_{GS} = 0 V,$ $V_{DS} = 25 V$		_	920	_	pF	
Reverse Transfer Capacitance	C _{rss}	$v_{DS} = 25 v$, f = 1.0 MHz, see fig. 5		_	170	-			
Total Gate Charge	Q _g				-	-	66		
Gate-Source Charge	-	$V_{GS} = 5.0 \text{ V} \qquad \begin{array}{c} I_{D} = 51 \text{ A}, V_{DS} = 48 \text{ V},\\ \text{see fig. 6 and } 13^{\text{b}} \end{array}$			-	-	12	nC	
Gate-Drain Charge	Q _{gs}			g. 6 and 13 ^b	_	_	43		
Ũ	Q _{gd}				-				
Turn-On Delay Time	t _{d(on)}				-	17	-	- ns	
Rise Time	t _r		= 30 V, I _D = 3 ₂ = 0.56 C	51 A, 2, see fig. 10 ^b	-	230	-		
Turn-Off Delay Time	t _{d(off)}	ng – 4.0 32, 1	ID = 0.00 S	2, 300 lig. 10	-	2	-		
Fall Time	t _f				-	110	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") f	rom		-	4.5	-	nH	
Internal Source Inductance	L _S	package and center of		-	7.5	-			
Drain-Source Body Diode Characteristic	cs	•							
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the			-	-	50 ^c	•	
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode			200	A			
Body Diode Voltage	V _{SD}	$T_J = 25 \text{ °C}, I_S = 51 \text{ A}, V_{GS} = 0 \text{ V}^{b}$ -		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	- 130 1		180	ns				
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = 51 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}^{b}$ - 0.84			1.3	μC			
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)							

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



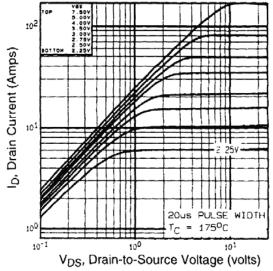
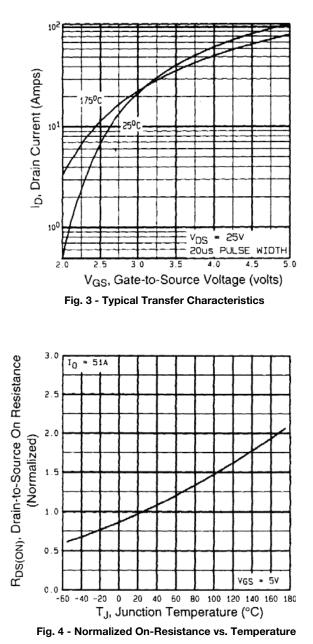


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C





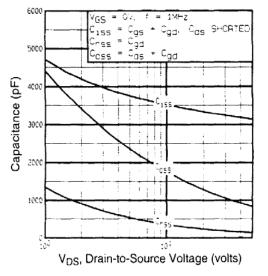


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

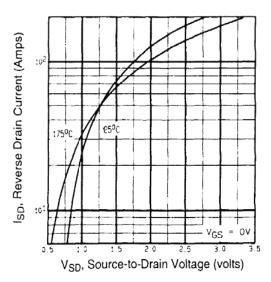
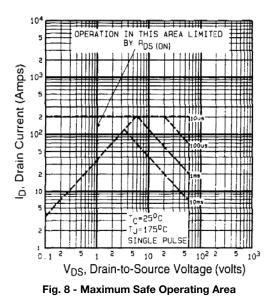


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





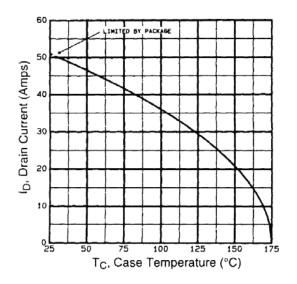


Fig. 9 - Maximum Drain Current vs. Case Temperature

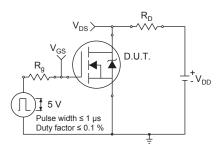


Fig. 10a - Switching Time Test Circuit

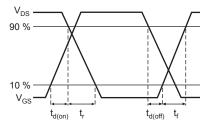
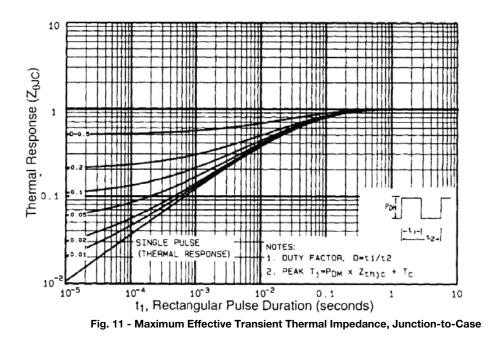


Fig. 10b - Switching Time Waveforms





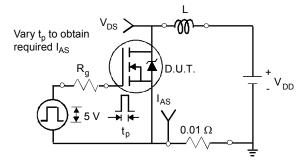


Fig. 12a - Unclamped Inductive Test Circuit

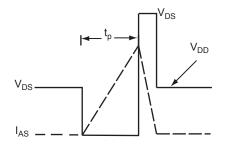


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

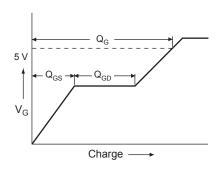


Fig. 13a - Basic Gate Charge Waveform

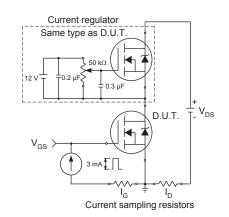
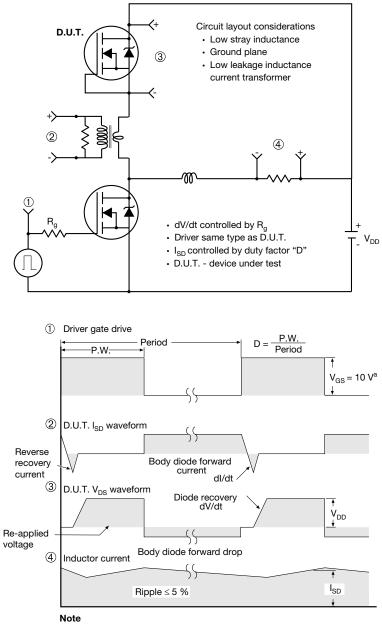


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

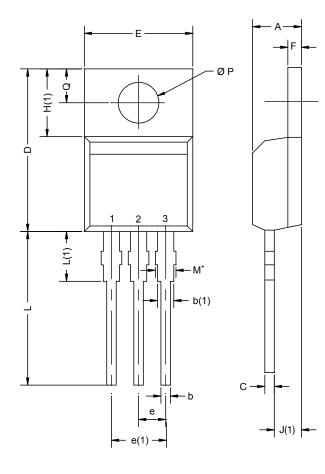


a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



TO-220AB



	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
E	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12		

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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